Search Notes



Application/Control No.

Applicant(s)/Patent Under

Reexamination

CHANG, CHIEN-JEN

Examiner

10764241

Art Unit

Scott Jr, Thomas E

2609

SEARCHED

Class	Subclass	Date	Examiner
345	89,589-605	3/20/2007	TESJR
349	142	3/16/2007	TESJR

SEARCH NOTES

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Search Notes	Date	Examiner
Attached EAST search and inventor search	3/19/2007	TESJR

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
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